## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10791299	HOSMER ET AL.
Examiner	Art Unit
Justin Y Lee	2617

SEARCHED				
Class	Subclass	Date	Examiner	
455	412.1, 412.2, 414.1, 414.2, 414.3, 414.4, 456.3, 3.02, 3.06	4/15/2008	/JL/	
709	219, 229, 225, 218, 206	12/3/2008	/JL/	
707	1, 10	12/3/2008	/JL/	
705	14	12/3/2008	/JL/	
725	119	12/3/2008	/JL/	

SEARCH NOTES				
Search Notes	Date	Examiner		
Duc Nguyen	4/15/2008	/JL/		
East	4/15/2008	/JL/		
Inventor Search	4/15/2008	/JL/		
updated inventor search	12/2/2008	/JL/		
interference searched (text search)	12/2/2008	/JL/		
consulted with Jean Gelin (primary in 2617)	12/3/2008	/JL/		
consulted with Sharad Rampuria (primary in 2617)	12/3/2008	/JL/		
updated inventor search	3/25/2009	/JL/		
updated East Search	3/25/2009	/JL/		
Alex Eisen (supervisor in 2617)	12/10/08	/JL/		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
455	412.1, 412.2, 414.1, 414.2, 414.3, 414.4, 456.3, 3.02, 3.06	12/3/2008	/JL/	
709	219, 229, 225, 218, 206	12/3/2008	/JL/	
707	1, 10	12/3/2008	/JL/	
705	14	12/3/2008	/JL/	
725	119	12/3/2008	/JL/	

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